

sub-picoamp instrumentation or any high impedance signal sources. Sourced from Process 53.

Absolute Maximum Ratings* TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
V_{DG}	Drain-Gate Voltage	40	V
V _{GS}	Gate-Source Voltage	- 40	V
I_{GF}	Forward Gate Current	50	mA
T _J ,T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C

*These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES:

1) These ratings are based on a maximum junction temperature of 150 degrees C.
2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Thermal Characteristics TA = 25°C unless otherwise noted

Symbol	Characteristic	N	Units	
		PN4117-4119	*MMBF4117-4119	
PD	Total Device Dissipation	350	225	mW
	Derate above 25°C	2.8	1.8	mW/°C
$R_{\theta JC}$	Thermal Resistance, Junction to Case	125		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	357	556	°C/W

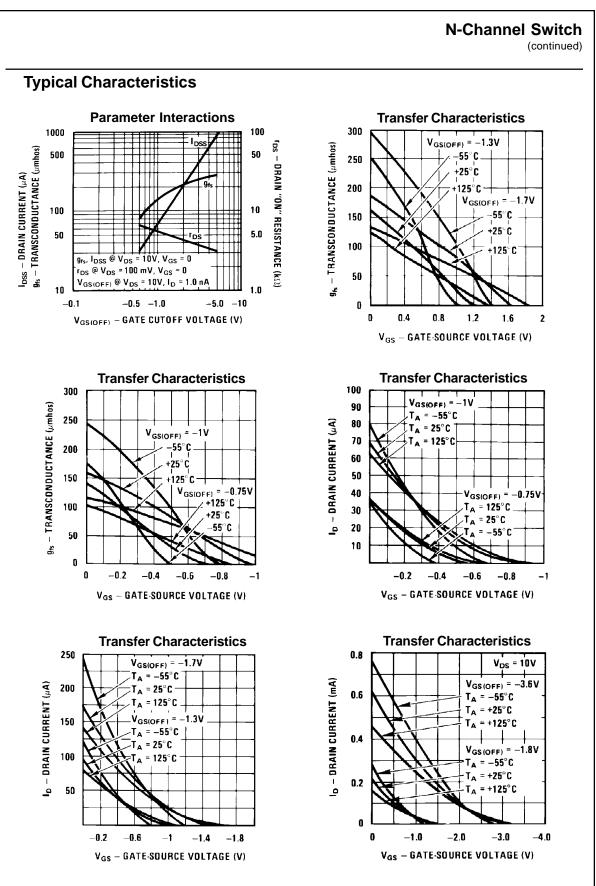
*Device mounted on FR-4 PCB 1.6" X 1.6" X 0.06."

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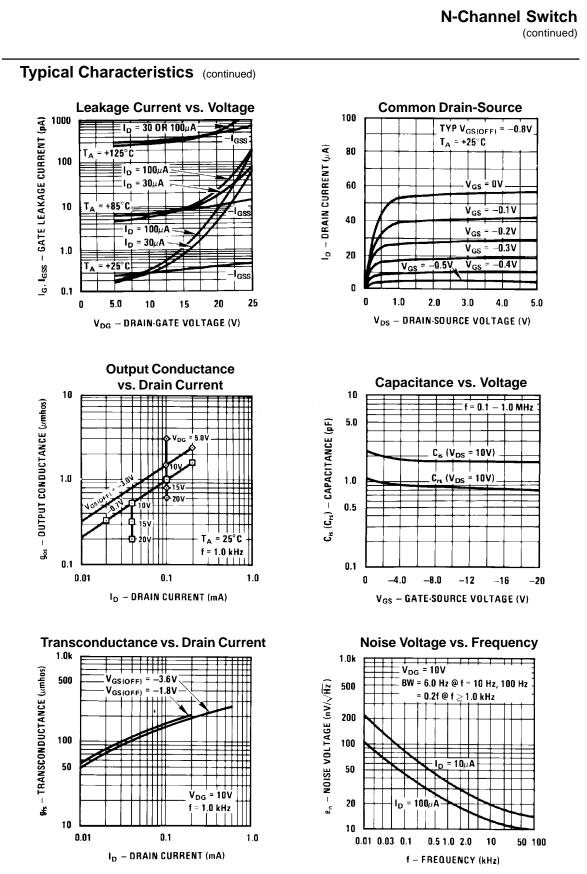
N-Channel Switch (continued)

Symbol	Parameter	Test Conditions	Min	Max	Units
OFF CHAI	RACTERISTICS				
V _{(BR)GSS}	Gate-Source Breakdown Voltage	I _G = - 1.0 μA, V _{DS} = 0	- 40		V
I _{GSS}	Gate Reverse Current			- 10 - 25	pA nA
V _{GS(off)}	Gate-Source Cutoff Voltage	V _{DS} = - 10 V, I _D = 1.0 nA 4117 4118 4119	- 0.6 - 1.0 - 2.0	- 1.8 - 3.0 - 6.0	V V V
		4118	80	240	μΑ
		4119	200	600	μA
SMALL-S		4119	200	600	μA
SMALL-S g _{fs}	IGNAL CHARACTERISTICS Common-Source Forward Transconductance	4119 V _{DS} = 10 V V _{GS} = 0, f= 1.0 kHz 4117 4118 4119	200 70 80 100	210 250 330	μmhos μmhos μmhos
	Common-Source Forward	$V_{DS} = 10 \text{ V } V_{GS} = 0, \text{ f} = 1.0 \text{ kHz} \\ 4117 \\ 4118 \\ 4119 \\ V_{DS} = 10 \text{ V } V_{GS} = 0, \text{ f} = 1.0 \text{ kHz} \\ 4117 \\ 4118 \\ 4119 \\ 4119 \\ 4119 \\ 4119 \\ 4119 \\ 4119 \\ 4119 \\ 4119 \\ 4110 \\ 410 \\ $	70 80	210 250	μmhos μmhos
gfs Goss	Common-Source Forward Transconductance Common-Source Output	$V_{DS} = 10 \ V \ V_{GS} = 0, \ f= 1.0 \ \text{kHz} \\ 4117 \\ 4118 \\ 4119 \\ V_{DS} = 10 \ V \ V_{GS} = 0, \ f= 1.0 \ \text{kHz} \\ 4117 \\ 4118 \\ 4117 \\ 4118 $	70 80	210 250 330 3.0 5.0	μmhos μmhos μmhos μmhos μmhos
9fs	Common-Source Forward Transconductance Common-Source Output Conductance Common-Source Forwad	$V_{DS} = 10 \text{ V } V_{GS} = 0, \text{ f} = 1.0 \text{ kHz} \\ 4117 \\ 4118 \\ 4119 \\ V_{DS} = 10 \text{ V } V_{GS} = 0, \text{ f} = 1.0 \text{ kHz} \\ 4117 \\ 4118 \\ 4119 \\ V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 30 \text{ MHz} \\ 4117 \\ 4118 \\ 4117 \\ 4118 \\$	70 80 100 60 70	210 250 330 3.0 5.0	μmhos μmhos μmhos μmhos μmhos μmhos μmhos μmhos

PN4117 / 4118 / 4119 / MMBF4117 / 4118 / 4119



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